

**Notice of References Cited**

Application/Control No.

10/592,008

Applicant(s)/Patent Under  
Reexamination  
WAKABAYASHI ET AL.

Examiner

Benny Lee

Art Unit

2817

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,129,097	10-2006	Furukawa et al.	438/1
*	B	US-7,160,532	01-2007	Liu et al.	423/447.3
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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